

## General Description

The WSD3030DN33 is the highest performance trench N-Channel MOSFET with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSD3030DN33 meet the RoHS and Green Product requirement 100%  $E_{AS}$  guaranteed with full function reliability approved.

## Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent  $CdV/dt$  effect decline
- 100%  $E_{AS}$  Guaranteed
- Green Device Available

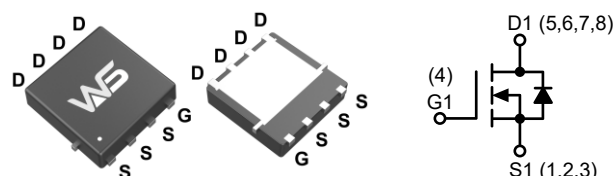
## Product Summary

| $BV_{DSS}$ | $R_{DS(ON)}$ | $I_D$ |
|------------|--------------|-------|
| 30V        | 15m $\Omega$ | 34A   |

## Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

## DFN3X3-8L Pin Configuration



## Absolute Maximum Ratings

| Symbol                    | Parameter   | Rating     | Units      |
|---------------------------|---|------------|------------|
| $V_{DS}$                  | Drain-Source Voltage                                  | 30         | V          |
| $V_{GS}$                  | Gate-Source Voltage                                   | $\pm 20$   |            |
| $I_D @ T_C = 25^\circ C$  | Continuous Drain Current, $V_{GS} @ 10V$ <sup>1</sup> | 34         | A          |
| $I_D @ T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$ <sup>1</sup> | 21         |            |
| $I_D @ T_A = 25^\circ C$  | Continuous Drain Current, $V_{GS} @ 10V$ <sup>1</sup> | 12         |            |
| $I_D @ T_A = 70^\circ C$  | Continuous Drain Current, $V_{GS} @ 10V$ <sup>1</sup> | 10         |            |
| $I_{DM}$                  | Pulsed Drain Current <sup>2</sup>                     | 80         |            |
| $E_{AS}$                  | Single Pulse Avalanche Energy <sup>3</sup>            | 25         | mJ         |
| $I_{AS}$                  | Avalanche Current                                     | 23         | A          |
| $P_D @ T_C = 25^\circ C$  | Power Dissipation <sup>4</sup>                        | 25         | W          |
| $P_D @ T_A = 25^\circ C$  | Power Dissipation <sup>4</sup>                        | 2.5        |            |
| $T_{STG}$                 | Storage Temperature Range                             | -55 to 150 | $^\circ C$ |
| $T_J$                     | Operating Junction Temperature Range                  | -55 to 150 |            |

## Thermal Data

| Symbol          | Parameter  | Typ. | Max. | Units        |
|-----------------|--|------|------|--------------|
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient <sup>1</sup> | ---  | 70   | $^\circ C/W$ |
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case <sup>1</sup>    | ---  | 5    |              |

**Electrical Characteristics** ( $T_J=25^{\circ}\text{C}$ , Unless Otherwise Noted)

| Symbol                       | Parameter                                      | Conditions  | Min. | Typ.   | Max.      | Units                  |
|------------------------------|--|---|------|--------|-----------|------------------------|
| $BV_{DSS}$                   | Drain-Source Breakdown Voltage                 | $V_{GS}=0V$ , $I_D=250\mu A$  | 30   | ---    | ---       | V                      |
| $\Delta BV_{DSS}/\Delta T_J$ | $BV_{DSS}$ Temperature Coefficient             | Reference to $25^{\circ}\text{C}$ , $I_D=1mA$                             | ---  | 0.0232 | ---       | V/ $^{\circ}\text{C}$  |
| $R_{DS(ON)}$                 | Static Drain-Source On-Resistance <sup>2</sup> | $V_{GS}=10V$ , $I_D=20A$  | ---  | 15     | 18        | m $\Omega$             |
|                              |  | $V_{GS}=4.5V$ , $I_D=10A$   | ---  | 23     | 28        |                        |
| $V_{GS(th)}$                 | Gate Threshold Voltage                         | $V_{GS}=V_{DS}$ , $I_D=250\mu A$  | 1.3  | 1.9    | 2.8       | V                      |
| $\Delta V_{GS(th)}$          | $V_{GS(th)}$ Temperature Coefficient           |   | ---  | -5.08  | ---       | mV/ $^{\circ}\text{C}$ |
| $I_{DSS}$                    | Drain-Source Leakage Current                   | $V_{DS}=24V$ , $V_{GS}=0V$ , $T_J=25^{\circ}\text{C}$                     | ---  | ---    | 1.0       | $\mu A$                |
|                              |  | $V_{DS}=24V$ , $V_{GS}=0V$ , $T_J=55^{\circ}\text{C}$                     | ---  | ---    | 5.0       |                        |
| $I_{GSS}$                    | Gate-Source Leakage Current                    | $V_{DS}=0V$ , $V_{GS}=\pm 20V$  | ---  | ---    | $\pm 100$ | nA                     |
| $g_{fs}$                     | Forward Transconductance                       | $V_{DS}=5V$ , $I_D=30A$   | ---  | 34     | ---       | S                      |
| $R_g$                        | Gate Resistance                                | $V_{DS}=0V$ , $V_{GS}=0V$ , $f=1.0MHz$                                    | ---  | 2.5    | 3.3       | $\Omega$               |
| $Q_g$                        | Total Gate Charge (4.5V)                       | $V_{DS}=15V$ , $V_{GS}=4.5V$ , $I_D=20A$                                  | ---  | 6.1    | 8         | nC                     |
| $Q_{gs}$                     | Gate-Source Charge                             |   | ---  | 2.4    | 2.9       |                        |
| $Q_{gd}$                     | Gate-Drain Charge                              |   | ---  | 2.3    | 3.2       |                        |
| $T_{d(on)}$                  | Turn-On Delay Time                             | $V_{DD}=15V$ , $V_{GEN}=10V$ , $R_G=6\Omega$<br>$I_D=1A$ , $R_L=15\Omega$ | ---  | 8      | 14        | ns                     |
| $T_r$                        | Rise Time                                      |   | ---  | 10     | 17        |                        |
| $T_{d(off)}$                 | Turn-Off Delay Time                            |   | ---  | 23     | 62        |                        |
| $T_f$                        | Fall Time                                      |   | ---  | 5      | 12        |                        |
| $C_{iss}$                    | Input Capacitance                              | $V_{DS}=15V$ , $V_{GS}=0V$ , $f=1.0MHz$                                   | ---  | 760    | 910       | pF                     |
| $C_{oss}$                    | Output Capacitance                             |   | ---  | 130    | 155       |                        |
| $C_{rss}$                    | Reverse Transfer Capacitance                   |   | ---  | 70     | 94        |                        |

**Guaranteed Avalanche Characteristics**

| Symbol   | Parameter                                  | Conditions                              | Min. | Typ. | Max. | Units |
|----------|--|---|------|------|------|-------|
| $E_{AS}$ | Single Pulse Avalanche Energy <sup>5</sup> | $V_{DD}=25V$ , $L=0.1mH$ , $I_{AS}=23A$ | 23   | ---  | ---  | mJ    |

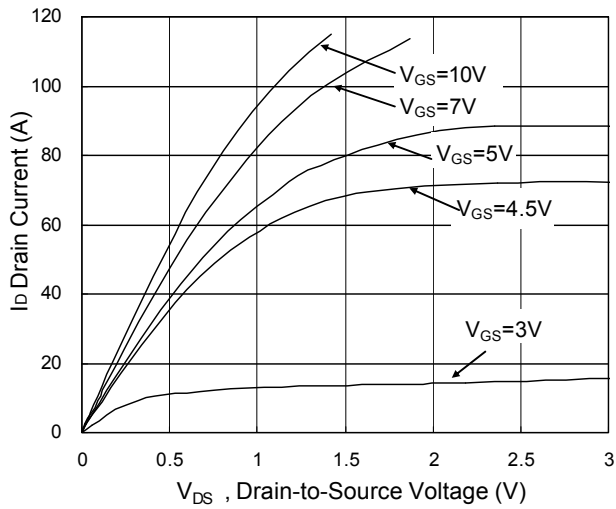
**Diode Characteristics**

| Symbol   | Parameter                                | Conditions  | Min. | Typ. | Max. | Units |
|----------|--|---|------|------|------|-------|
| $I_S$    | Continuous Source Current <sup>1,6</sup> | $V_G=V_D=0V$ , Force Current                              | ---  | ---  | 1.0  | A     |
| $I_{SM}$ | Pulsed Source Current <sup>2,6</sup>     |   | ---  | ---  | 80   | A     |
| $V_{SD}$ | Diode Forward Voltage <sup>2</sup>       | $V_{GS}=0V$ , $I_S=1A$ , $T_J=25^{\circ}\text{C}$         | ---  | ---  | 1.0  | V     |
| $t_{rr}$ | Reverse Recovery Time                    | $I_F=20A$ , $dI/dt=100A/\mu s$ , $T_J=25^{\circ}\text{C}$ | ---  | 18.5 | ---  | ns    |
| $Q_{rr}$ | Reverse Recovery Charge                  |   | ---  | 10   | ---  | nC    |

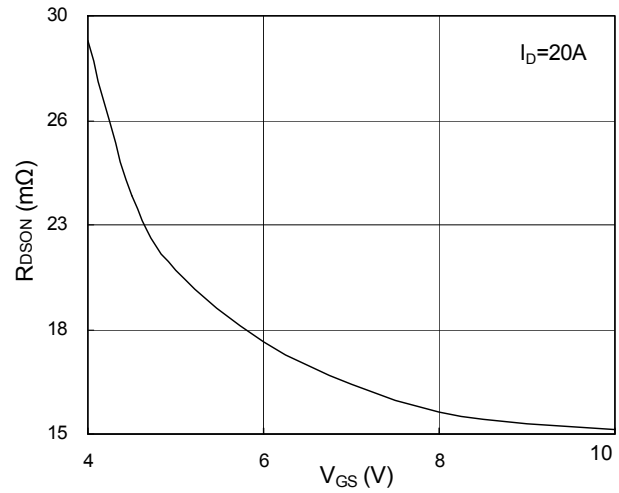
Note:

- The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 20Z copper,  $t<10\text{sec}$ .
- The data tested by pulsed, pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$
- The  $E_{AS}$  data shows Max. rating. The test condition is  $V_{DD}=25V$ ,  $V_{GS}=10V$ ,  $L=0.1mH$ ,  $I_{AS}=23A$
- The power dissipation is limited by  $150^{\circ}\text{C}$  junction temperature.
- The Min. value is 100%  $E_{AS}$  tested guarantee.
- The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.

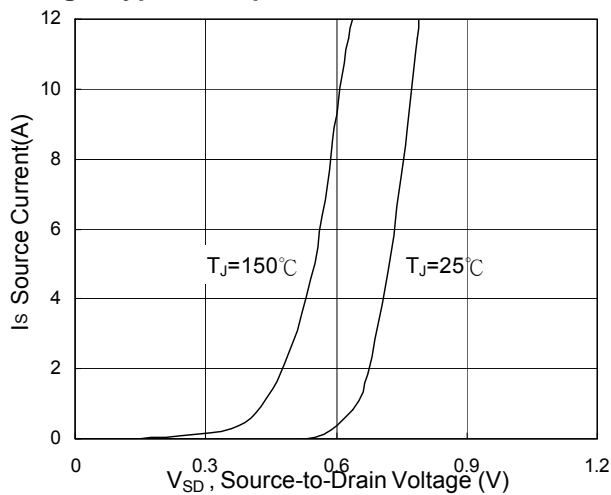
## Typical Characteristics



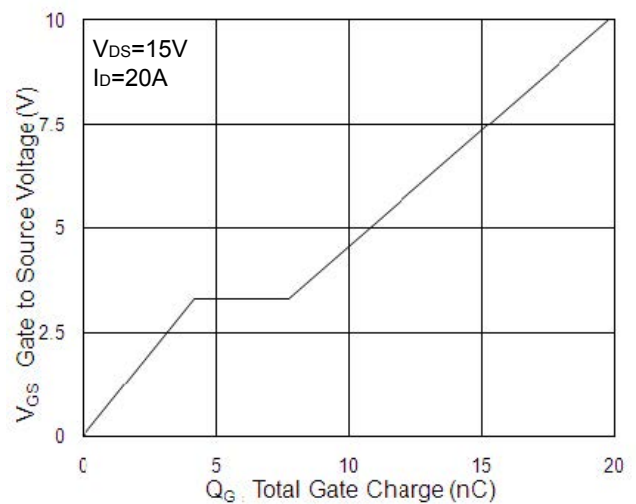
**Fig.1 Typical Output Characteristics**



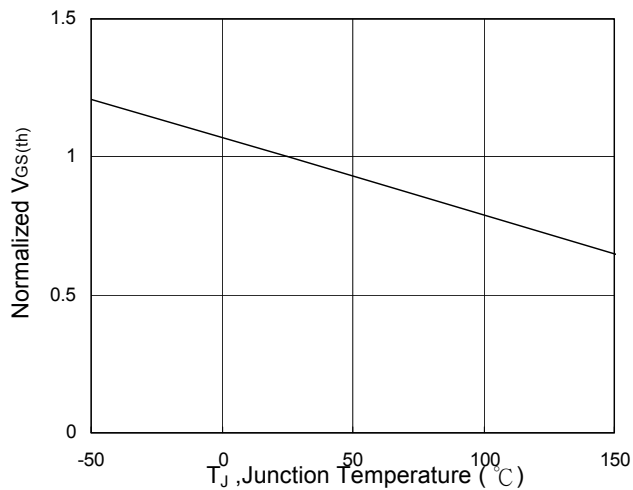
**Fig.2 On-Resistance vs. G-S Voltage**



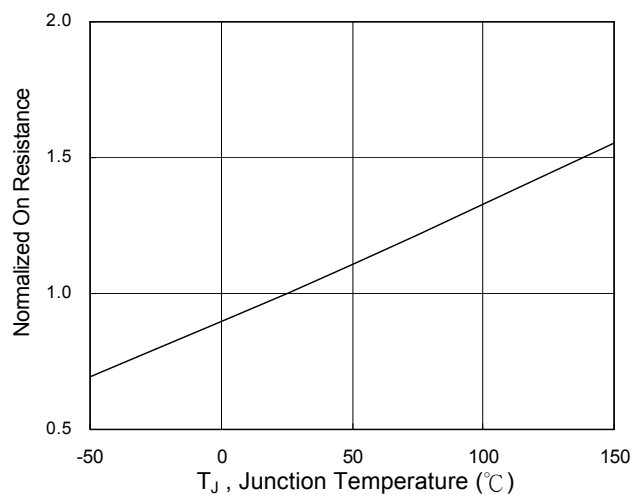
**Fig.3 Forward Characteristics of Reverse**



**Fig.4 Gate-charge Characteristics**

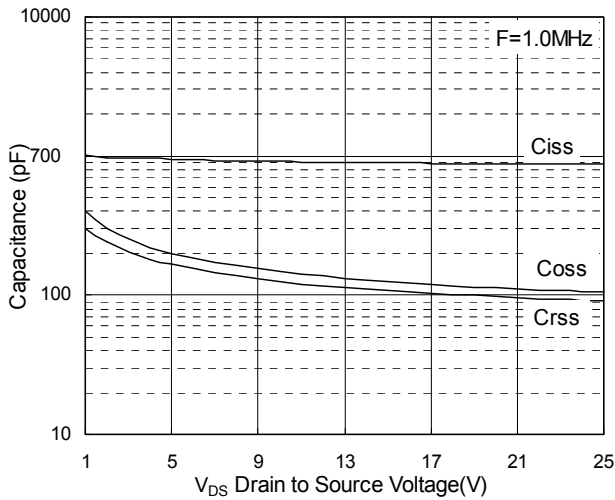


**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$**

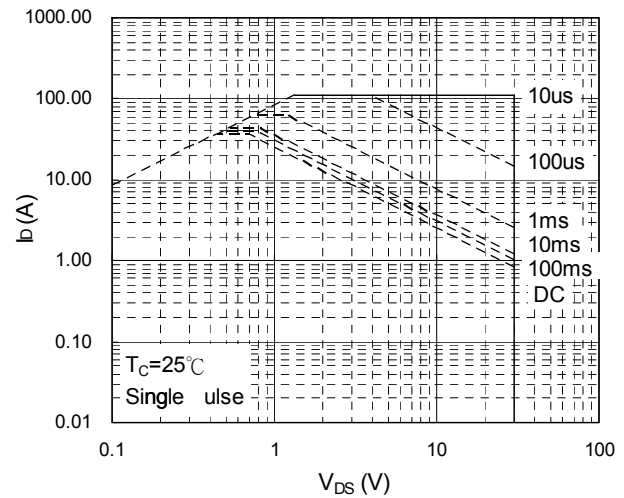


**Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$**

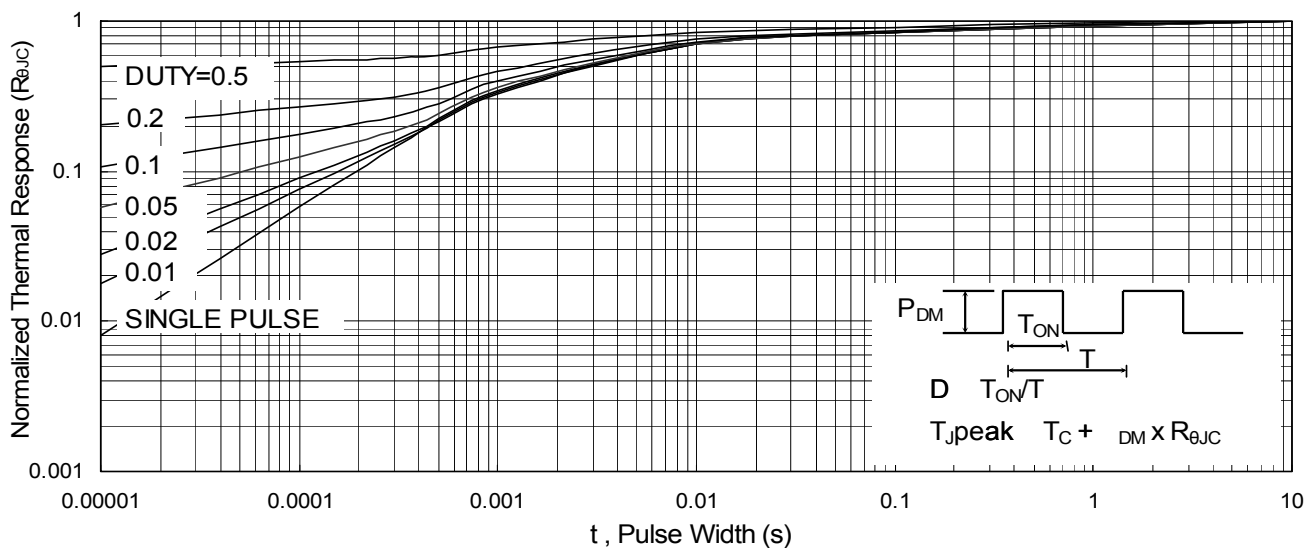
### Typical Characteristics (Cont.)



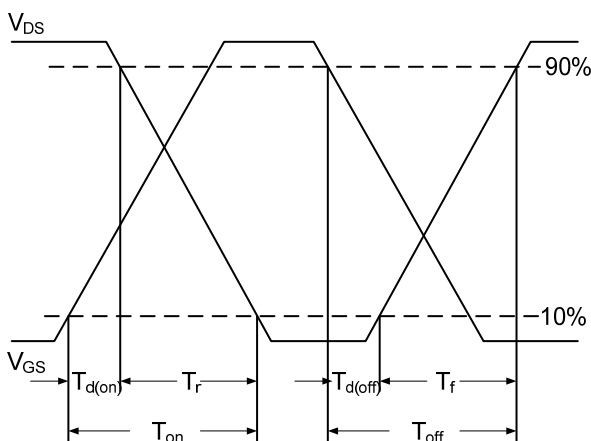
**Fig.7 Capacitance**



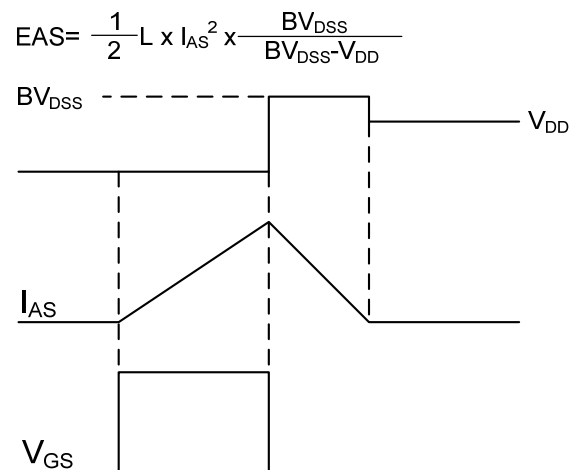
**Fig.8 Safe Operating Area**



**Fig.9 Normalized Maximum Transient Thermal Impedance**

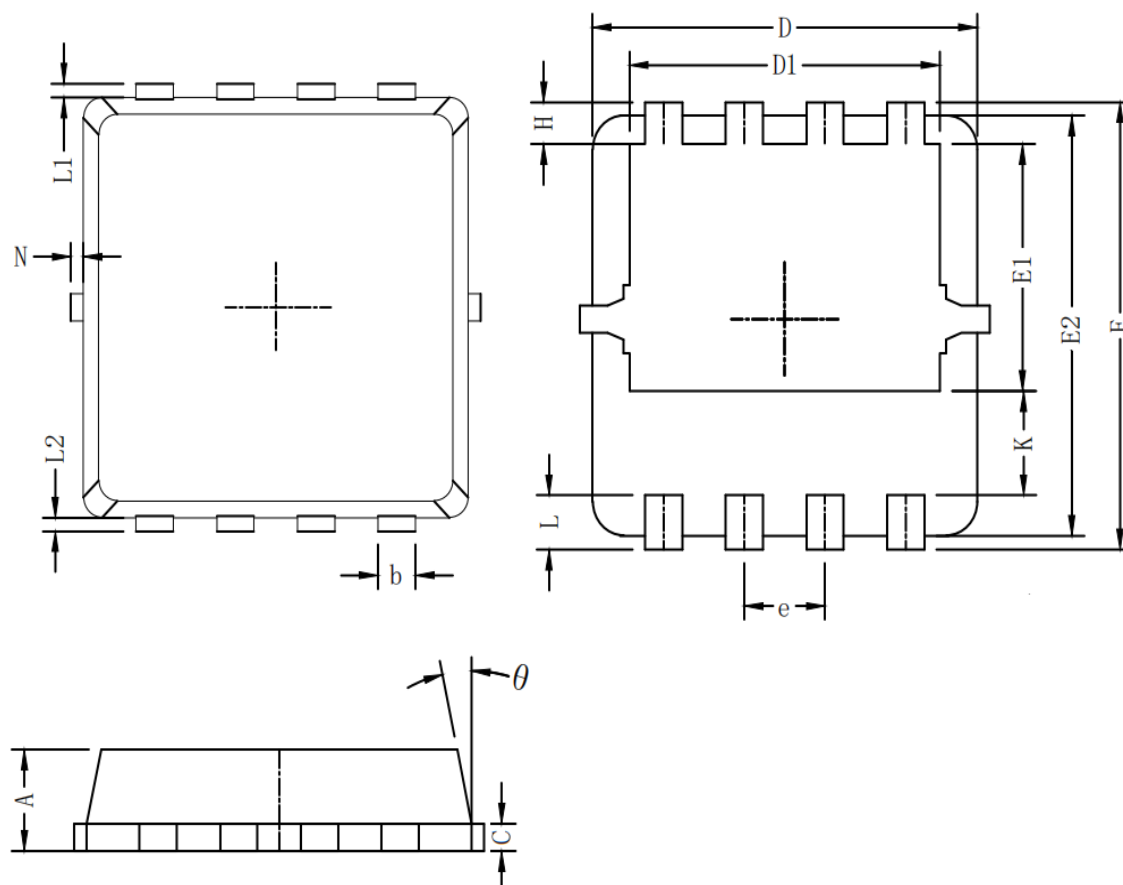


**Fig.10 Switching Time Waveform**



**Fig.11 Unclamped Inductive Switching Waveform**

## Packaging information



| Symbol   | Dim in mm |      |      |
|----------|-----------|------|------|
|          | min       | typ  | max  |
| A        | 0.6       | 0.75 | 0.9  |
| b        | 0.2       | 0.3  | 0.4  |
| C        | 0.15      | 0.2  | 0.25 |
| D        | 3         | 3.1  | 3.2  |
| D1       | 2.3       | 2.45 | 2.6  |
| E        | 3.15      | 3.3  | 3.45 |
| E1       | 1.43      | 1.73 | 1.93 |
| E2       | 2.9       | 3.05 | 3.2  |
| e        | 0.65BSC   |      |      |
| H        | 0.2       | 0.35 | 0.5  |
| K        | 0.57      | 0.77 | 0.87 |
| L        | 0.3       | 0.4  | 0.5  |
| L1/L2    | 0.1REF    |      |      |
| $\theta$ | 8°        | 10°  | 13°  |
| N        | 0         |      | 0.15 |

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